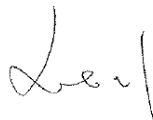


APPROVAL SHEET

Customer Name : _____
Customer P/N : _____
Frequency : 16.000000 MHz
Aker Approved P/N : SMAN-016000-2-D4-00
Aker MPN : SMAN-016000-2-D4-00
Rev. : 1
ISSUE DATE : Feb.10.2023

APPROVED	CHECKED	PREPARED
		Jimmy
APPROVED BY CUSTOMER		

AKER TECHNOLOGY CO., LTD.

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TEL : 886-4-25335978 FAX : 886-4-25336011

Web: www.aker.com.tw

**MSL:Level 1
RoHS compliant**



Aker Approved P/N :		SMAN-016000-2-D4-00	
APPROVED	:	Xtal	SHEET : 2 of 10
PREPARED	:	Jimmy	REV . : 1
Confidential			

SMD CRYSTAL OSCILLATOR

1 . ELECTRICAL CHARACTERISTICS

■ Standard atmospheric conditions

Unless otherwise specified , the standard range of atmospheric conditions for making measurement and tests are as follow :

Ambient temperature : $25 \pm 5^\circ\text{C}$

Relative humidity : 40%~70%

If there is any doubt about the results , measurement shall be made within the following limits :

Ambient temperature : $25 \pm 3^\circ\text{C}$

Relative humidity : 40%~70%

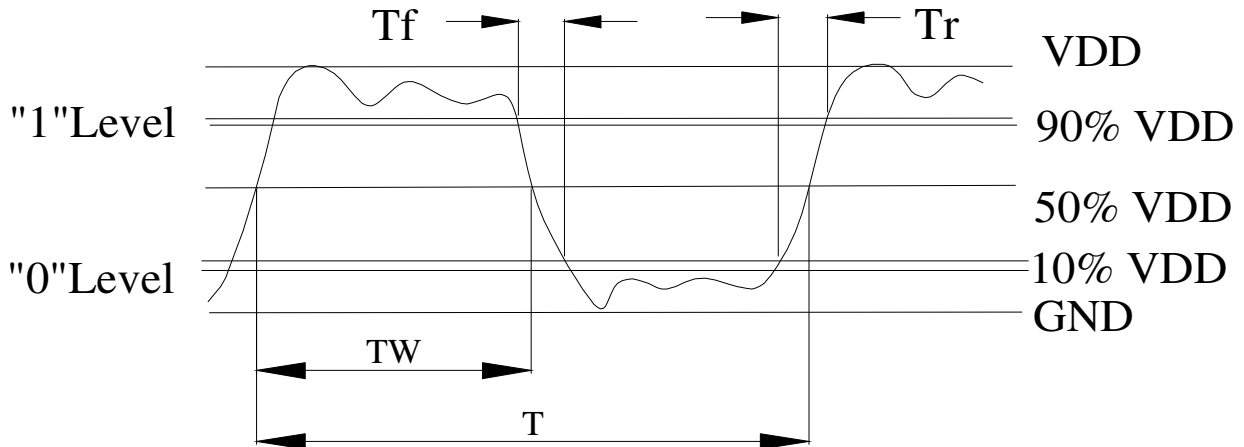
■ AKER Model : SMAN-221

■ Cutting Mode : AT CUT

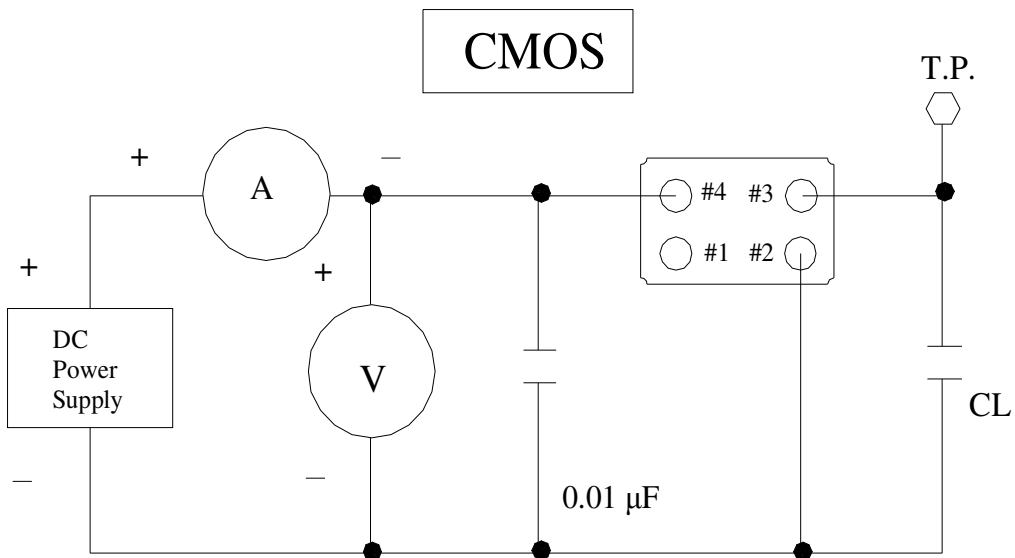
Parameters	Symbol	Electrical Spec				Notes
		Min.	Typ.	Max.	Units.	
Nominal Frequency		16.000000			MHz	
Frequency Stability		±50			ppm	
Supply Voltage	V _{cc}	1.62	~	3.63	V	
Output Load CMOS	CL			15	pF	
Aging		±3			ppm	First Year
Enable Control		Yes				Pad 1
Operating Temperature		-40	25	85	°C	
Storage Temperature Range		-55	~	125	°C	
Output Voltage High	VoH	90%V _{DD}			V	
Output Voltage Low	VoL			10%V _{DD}	V	
Input Current	I _{cc}			7	mA	
Standby Current	I _{st}			10	μA	
Rise Time	Tr			7	ns	10%~90%V _{DD} Level
Fall Time	Tf			7	ns	90%~10%V _{DD} Level
Symmetry (Duty ratio)	TH/T	45	~	55	%	
Start-up Time	T _{osc}			10	ms	
Enable Voltage High	V _{hi}	70%V _{DD}			V	
Disable Voltage Low	V _{lo}			30%V _{DD}	V	
Output Enable Delay Time	T _{on}			10	ms	
Output Disable Delay Time	T _{off}			200	ns	
Phase Jitter RMS				1	ps	12KHz~5MHz

Please kindly be noted that AKER DO NOT guarantee parts quality which involves human security application.

2. C - MOS LOAD OUTPUT WAVEFORM

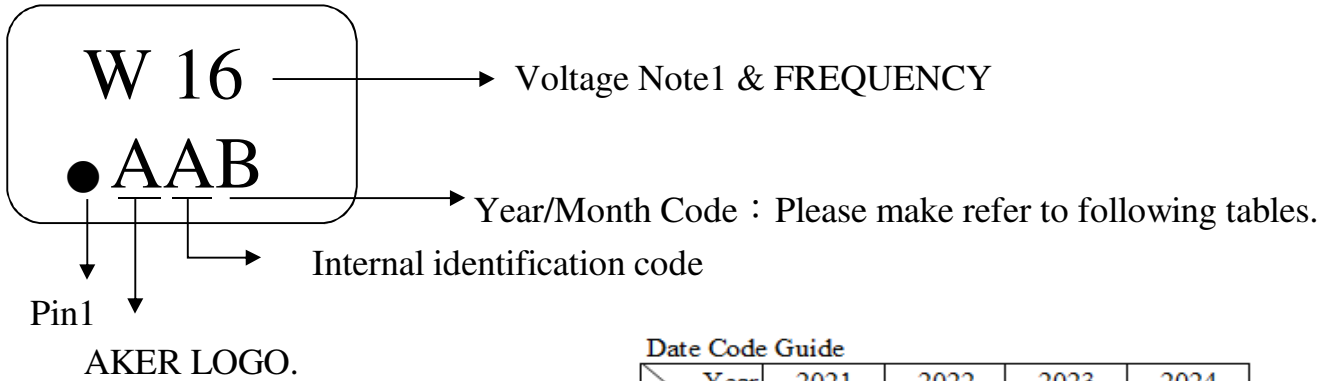


3. C - MOS LOAD TEST CIRCUIT



***Because SMA series has no by pass capacitor.
So, we recommend our customer to use capacitor 0.01 μ F
in join Vcc and GND.

4. MARKING :



NOTE1:

T	5.0V TTL
C	4.5~5.0V CMOS
L	2.97~3.63V TTL&CMOS
R	2.8~3.0V CMOS
S	2.25~2.75V CMOS
Y	1.5~2.0V CMOS
Z	0.8~1.4V CMOS
W	Voltage Range CMOS

Date Code Guide

Year	2021	2022	2023	2024
	2025	2026	2027	2028
Month	(4N+1)	(4N+2)	(4N+3)	(4N+0)
JAN	a	n	A	N
FEB	b	p	B	P
Mar	c	q	C	Q
Apr	d	r	D	R
May	e	s	E	S
Jun	f	t	F	T
Jul	g	u	G	U
Aug	h	v	H	V
Sep	j	w	J	W
Oct	k	x	K	X
Nov	l	y	L	Y
Dec	m	z	M	Z

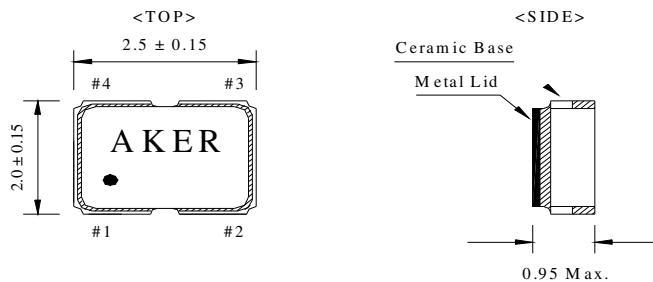
A cycle every four years

5. DIMENSION :

(UNIT : mm)

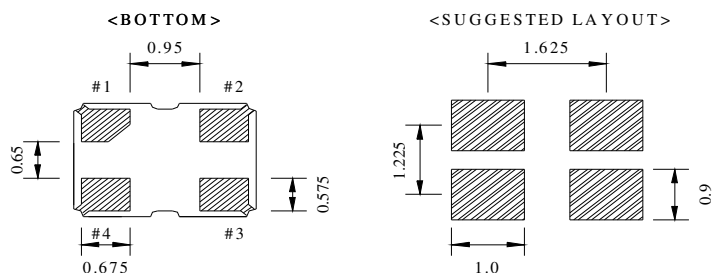
Enable / Disable Function

E/D (#1)	OUTPUT (#3)
HIGH (Open)	Operating
LOW	High impedance

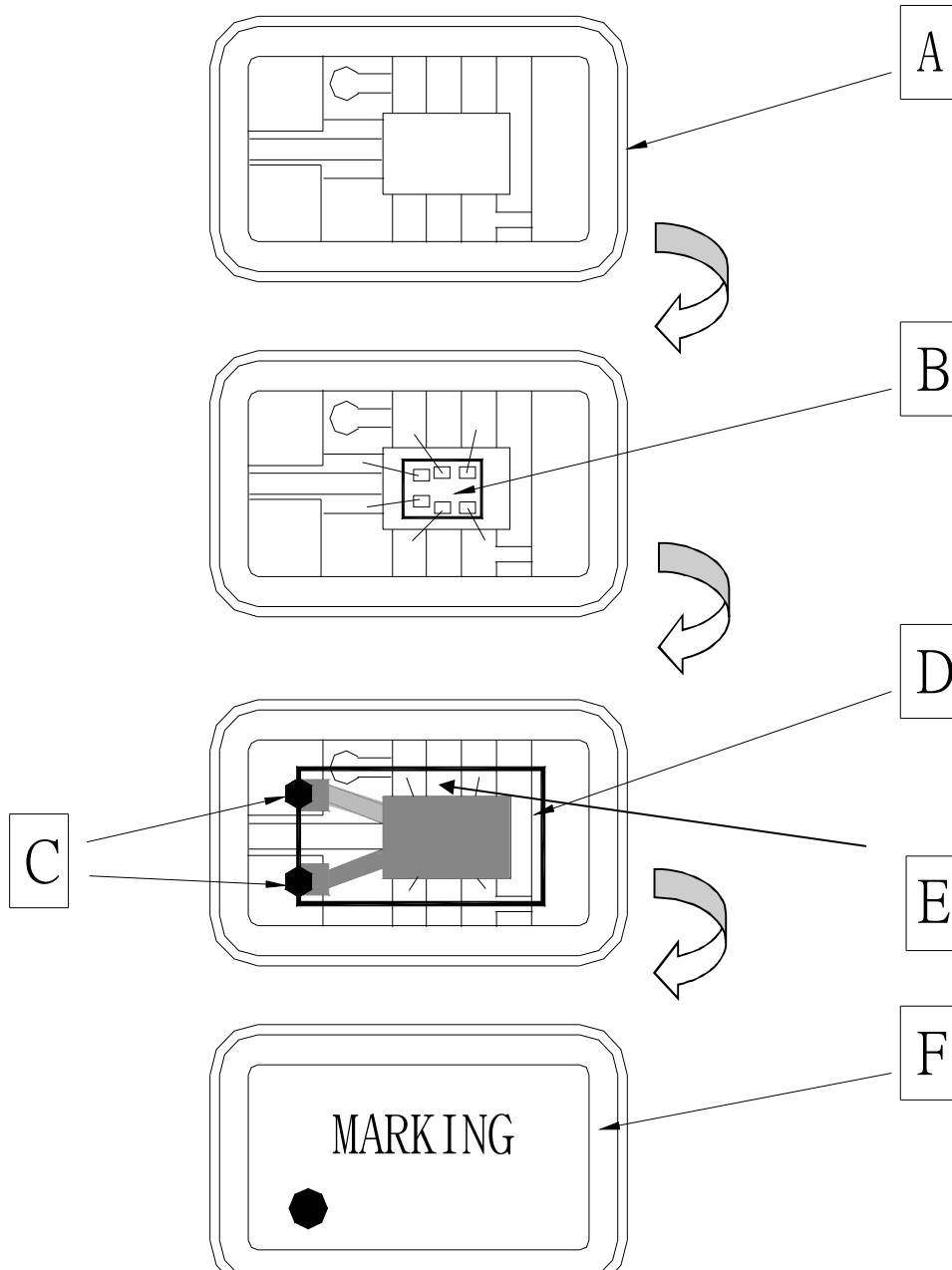


PIN FUNCTION

- #1 : Enable / Disable Control
- #2 : GND
- #3 : OUTPUT
- #4 : VDD



6 . STRUCTURE ILLUSTRATION

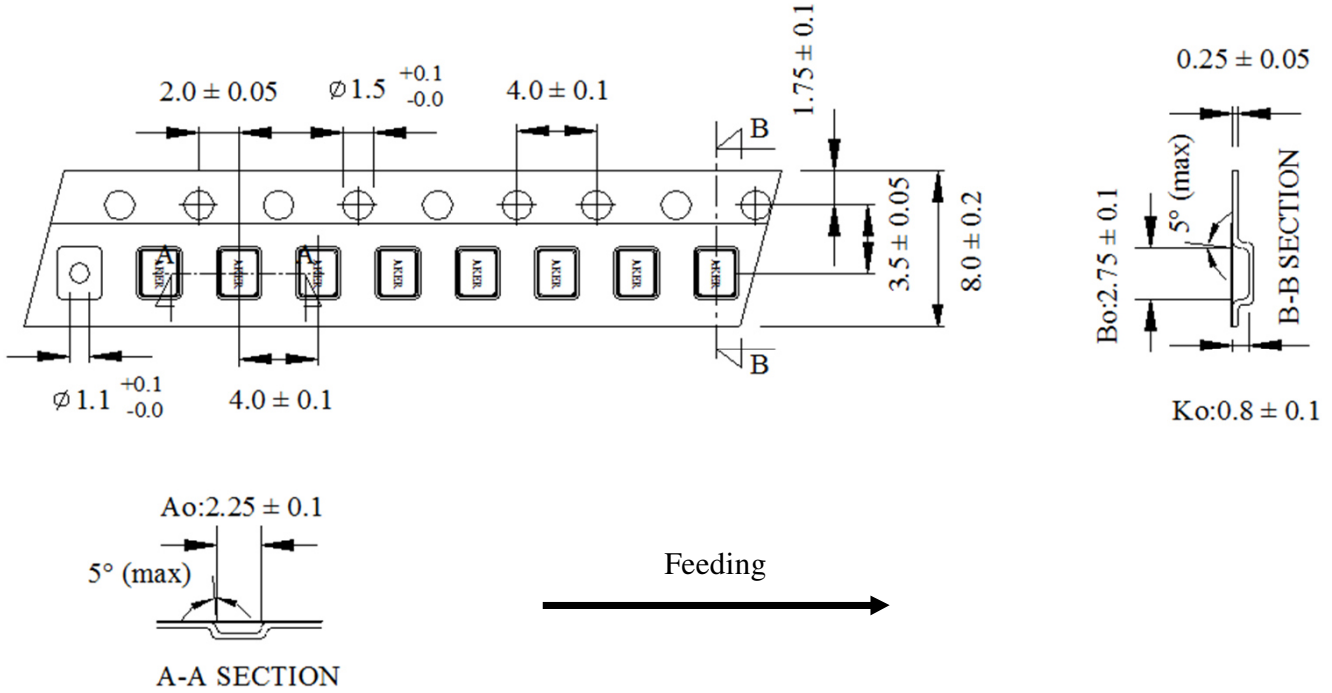


COMPONENTS		MATERIALS		COMPONENTS		MATERIALS	
A	Base (Package)	Ceramic (Al ₂ O ₃)+Kovar (Fe/Co/Ni)		D	Crystal blank	SiO ₂	
B	IC chip	.		E	Electrode	Cr / Ag	
C	Conductive adhesive	Ag / Silicon resin		F	Lid	Fe/Co/Ni	

7. PACKING :

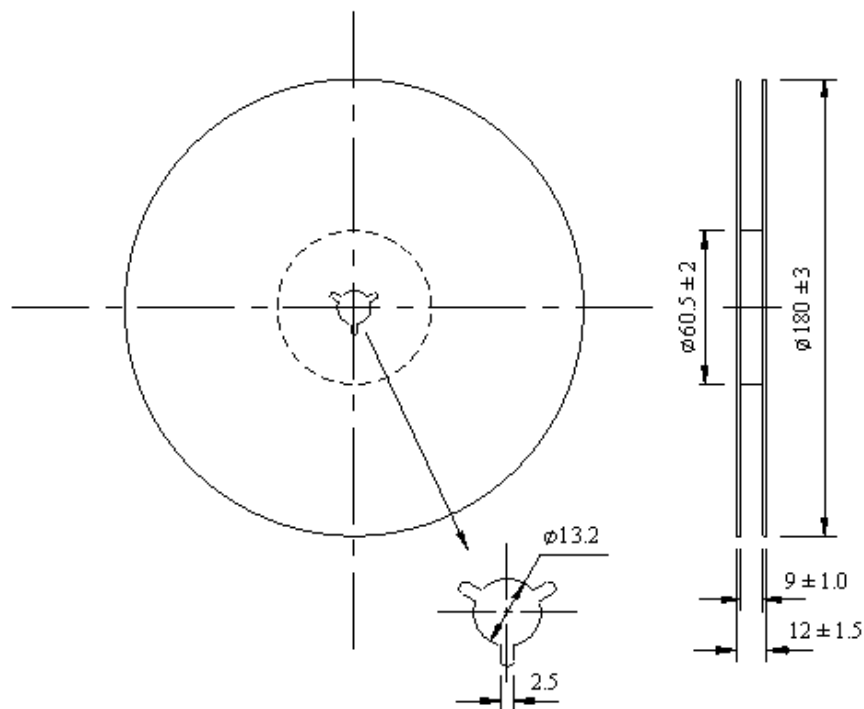
TAPE SPECIFICATION

(Unit : mm)

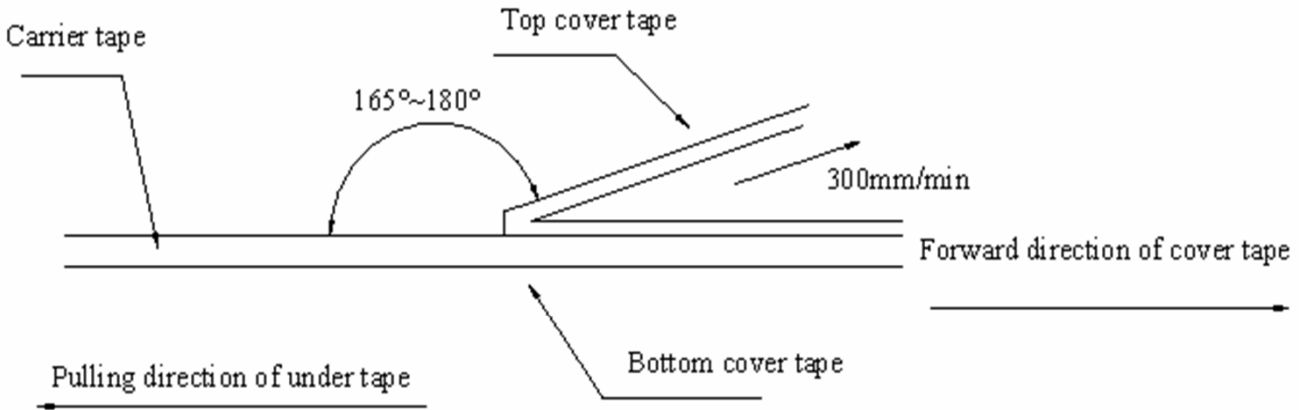


OUTLINE DIMENSION

(Unit : mm)



8. COVER TAPE ADHESION STRENGTH :

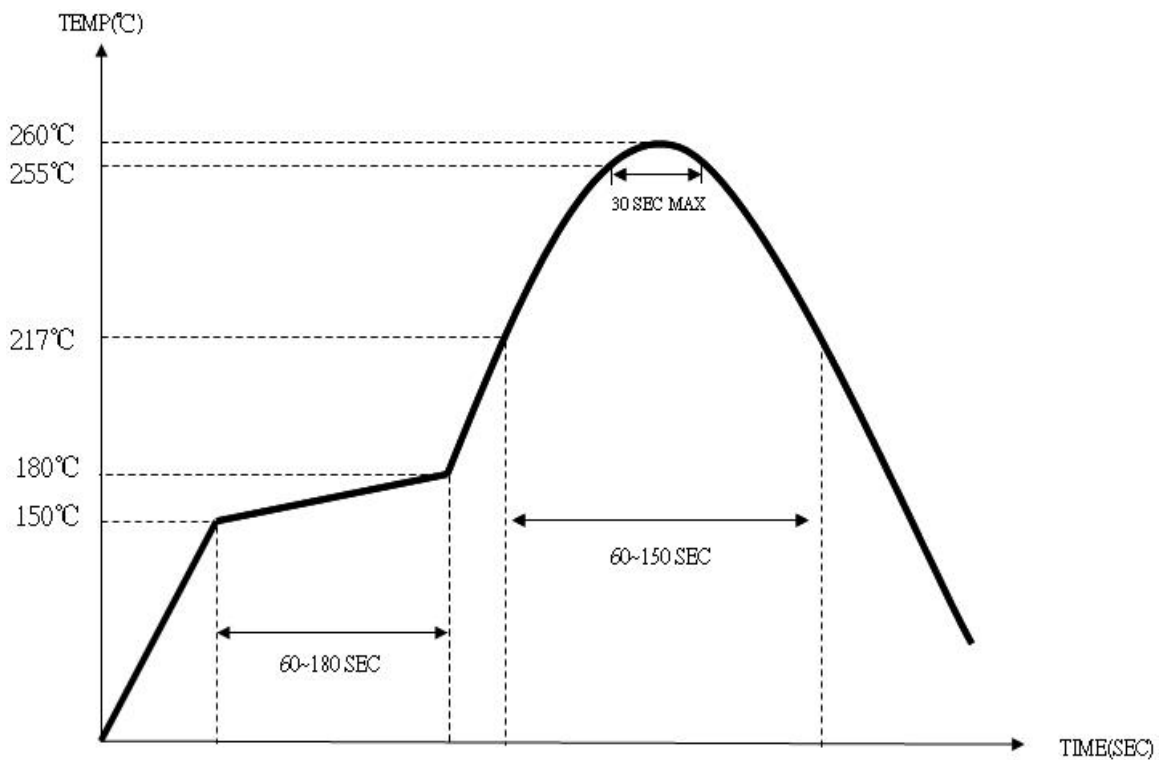


*** In the case, the cover tape is pulled off under the above conditions, the cover tape adhesion strength should be $10.2\text{g}\sim 71.4\text{g}$

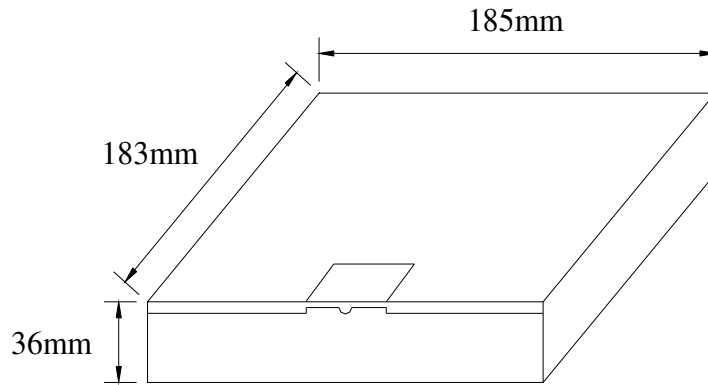
Plastic tape: $10.2\text{g}\sim 71.4\text{g}$

(Cover tape adhesion strength)

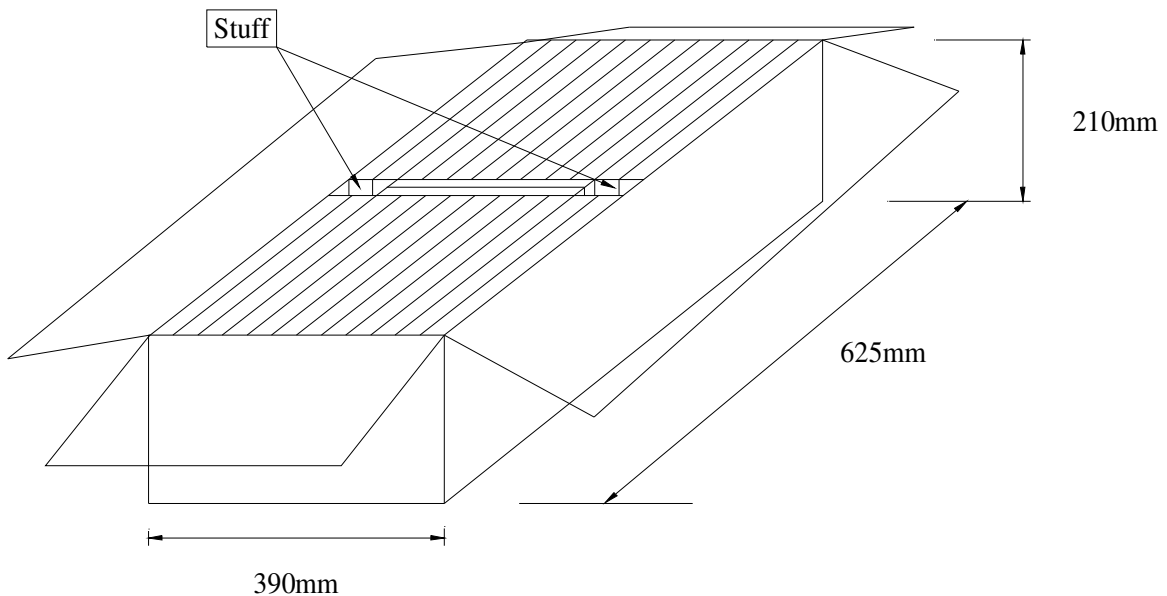
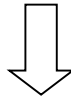
9. SOLDERING REFLOW PROFILE



10. PACKING :



BOX = 3000 PCS / REEL(MAX)



SMD product packs 52 BOX=1111 outside box packs (5000 PCS * 52 BOX = 90000 PCS)(MAX)

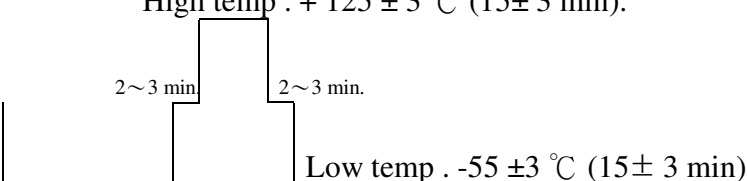


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APPROVED	:	Xtal	SHEET : 9 of 10
PREPARED	:	Jimmy	REV. : 1
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11. MECHANICAL PERFORMANCE

TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
11.1 Drop Test	The specimen is measured for its frequency before the test. It is then dropped from a height of 75 cm or more as a free fall object onto a hard wooden plate of 30mm or more in thickness. (in accordance with JIS-C0044)	To satisfy the electrical performance .
11.2 Vibration Test	The specimen is measured for its frequency before the test. Most them into X,Y and Z axes, respectively, for the vibration test. Vibration condition: Frequency range ; 20 ~ 2000HZ Peak to peak amplitude : 1.52 mm Peak acceleration : 20G Sweep time : 20 minute / axis Pendicular total test time : 4 hours (in accordance with MIL-STD-883F : 2007.3)	
11.3 Resistance to Soldering Test	The specimen is measured for its frequency before the test. Place the specimen on the belt of the conveyance and let it pass through the reflow with the presetted temperature condition. After passing twice the reflow place, the specimen under the referee condition for ~2 hours and then measure its electrical performance. Temperature Condition of IR Simulation: The temperature range of the preheated section is setted at 150 ~ 180°C for 60~120 sec. For the next section the temperature range is setted at 217~260°C for 45~90 sec. and within this time range the specimen should be able to sustain at the peak temperature, 260+/-3°C , for 10 sec long. (in accordance with JESD22-B106-B)	
11.4 Fine Leak Test	Place the specimen in a pressurized container and pressurize it with the detection gas (mixed gas consisting of 95% or more helium) for at least 2 hours. Complete the measurement of the concentration of helium within 30 min after taking it out from the pressurized container. (in accordance with MIL-STD-883F : 1014.11)	
The referee condition . Temperature 25 ± 2 °C Humidity 44 ~ 55 % Pressure 86 ~ 106 kPa (in accordance with MIL-STD-883E : 1014.9)		

12 . CLIMATIC RESISTANCE

TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
12.1 Low Temp Exposure Test	<p>The specimen is measured for its frequency before the test .</p> <p>Place the specimen in the chamber and kept it at the temperature of $-40 \pm 3^{\circ}\text{C}$ for 168 ± 6 hours .</p> <p>Take the specimen out of the chamber and measure its electrical performance after leaving 1 ~ 2 hours under the referee condition. (in accordance with JIS-C0020)</p>	To satisfy the electrical performance .
12.2 Aging Test	<p>The specimen is measured for its frequency before the test .</p> <p>Place the specimen in the testing chamber and keep it at the temperature of $+125 \pm 3^{\circ}\text{C}$ for 720 ± 48 hours. And then take the specimen out of the chamber and measure its electrical performance after leaving for 1 ~ 2 hours under the referee condition . (in accordance with JIS-C0021)</p>	
12.3 High Temperature & High Humidity	<p>The specimen is measured for its frequency before the test .</p> <p>Place the specimen in the testing chamber and kept it at the temperature of $+85 \pm 5^{\circ}\text{C}$ and humidity of $85 \pm 5\%$ for 168 ± 6 hours. and then take the specimen out and measure its electrical performance after leaving for 1 ~ 2 hours under the referee condition. (in accordance with MIL-STD-883F : 1004.7)</p>	
12.4 Temperature Cycle Test	<p>The specimen is measured for its frequency before the test .</p> <p>Subject the specimen to the 100 cycles of temperature ranges stated below .</p> <p style="text-align: center;">High temp . $+125 \pm 3^{\circ}\text{C}$ (15 ± 3 min).</p> <div style="text-align: center;">  <p>2~3 min 2~3 min.</p> <p style="text-align: center;">Low temp . $-55 \pm 3^{\circ}\text{C}$ (15 ± 3 min).</p> </div> <p>Measure its electrical performance after leaving it for 1 ~ 2 hours under the referee condition . (in accordance with MIL-STD-883F : 1010.8)</p>	